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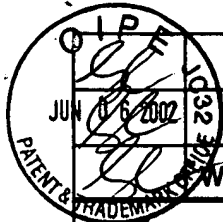
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U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>[Signature]</i>	2 5 9 4 3 3 4	4/52	Miller			
<i>[Signature]</i>	2 8 3 5 1 6 7	5/58	Pierce			
	2 9 7 5 6 6 9	3/61	Jarrell et al.			
	3 4 9 0 8 4 8	1/70	McPherson			
	3 9 0 9 1 3 4	9/75	Pieuchard et al.			
	3 9 3 0 7 2 8	1/76	Pieuchard et al.			
	3 9 8 5 4 4 3	10/76	Danielsson et al.			
	4 0 2 7 9 7 5	6/77	Turner et al.			
	4 0 6 8 9 5 4	1/78	Da Silva			
	4 0 8 7 1 8 3	5/78	Passereau			
	4 2 4 1 9 9 9	12/80	Pouey			
	4 3 0 0 8 3 5	11/81	Schiemann et al.			
	4 3 1 2 5 6 9	1/82	Harada et al.			
	4 4 5 5 0 8 8	6/84	Koike			
	4 5 7 5 2 4 2	3/86	Akiyama et al.			
<i>[Signature]</i>	4 6 1 8 2 6 0	10/86	Okubo			
	4 8 5 0 7 0 6	7/89	Mikes			
	5 0 6 6 1 2 7	11/91	Schwenker			

FOREIGN PATENT DOCUMENTS

Document Number	Date	Country	YES	NO
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2 6 5 3 8 7 9	5/91	France	<i>[Signature]</i>	



	5	7	4	9	8	2	2	3/82	Japan				
	6	2	4	9	3	0	8	3/87	Japan				
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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			J. Thomas Brownrigg, "Design and performance of a miniature dual-beam diode-array spectrometer," <i>Spectroscopy</i> . vol. 10, Iss. 9 (Nov.-Dec., 1995), pp. 39-44
			L. Mertz, Concentric Spectrographs, " <i>Applied Optics</i> ," vol. 16, No. 12 (Dec. 1977), pp. 3122-3124

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